

Application No.	Applicant(s)	
10/021,423	RAGHAVAN ET AL.	
Examiner	Art Unit	
Linh V. Nauven	2810	

SEARCHED						
Class	Subclass	Date	Examiner			
330	53	1	a			
	124R					
	149	2/9/04	L			
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
330	149	2/9/04	L		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
I,Q, predistortion variable, amplifier	4	#			
input, detetion	2/9/04	L			